

<b>Notice of References Cited</b>	Application/Control No. 09/739,325	Applicant(s)/Patent Under Reexamination ATTIMONT ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,621,812	09-2003	Chapman et al.	370/346
*	B	US-5,897,613	04-1999	Chan, Norman C.	704/210
*	C	US-6,580,694	06-2003	Baker, Carl R.	370/252
*	D	US-5,995,491	11-1999	Richter et al.	370/263
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